


<b>Search Notes</b>  	<b>Application/Control No.</b>  10622951	<b>Applicant(s)/Patent Under Reexamination</b>  KWON ET AL.
	<b>Examiner</b>  Nguyen, Toan D	<b>Art Unit</b>  2616

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
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EAST (US-PGPUB; USPAT; EPO; IBM	6/6/08	TN
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INTERFERENCE SEARCH			
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